



CDC3RL02 Low Phase-Noise Two-Channel Clock Fan-Out Buffer

1 Features

- Low Additive Noise:
 - -149 dBc/Hz at 10-kHz Offset Phase Noise
 - 0.37 ps (RMS) Output Jitter
- Limited Output Slew Rate for EMI Reduction (1- to 5-ns/Rise/Fall Time for 10-pF to 50-pF Loads)
- Adaptive Output Stage Controls Reflection
- Regulated 1.8-V Externally Available I/O Supply
- Ultra-Small 8-bump YFP 0.4-mm Pitch WCSP (0.8 mm × 1.6 mm)
- ESD Performance Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 1000-V Charged-Device Model (JESD22-C101-A Level III)

2 Applications

- Cellular Phones
- Global Positioning Systems (GPS)
- Wireless LAN
- FM Radio
- WiMAX
- W-BT

3 Description

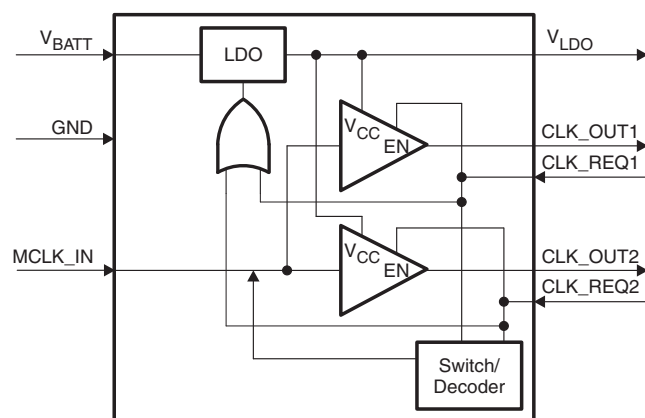
The CDC3RL02 is a two-channel clock fan-out buffer. It buffers a single master clock, such as a temperature compensated crystal oscillator (TCXO) to multiple peripherals. The device has two clock request inputs (CLK_REQ1 and CLK_REQ2), each of which enable a single clock output.

The CDC3RL02 accepts square or sine waves at the master clock input (MCLK_IN), eliminating the need for an AC coupling capacitor. The smallest acceptable sine wave is a 0.3-V signal (peak-to-peak). CDC3RL02 has been designed to offer minimal channel-to-channel skew, additive output jitter, and additive phase noise. The adaptive clock output buffers offer controlled slew-rate over a wide capacitive loading range which minimizes EMI emissions, maintains signal integrity, and minimizes ringing caused by signal reflections on the clock distribution lines.

The CDC3RL02 has an integrated Low-Drop-Out (LDO) voltage regulator which accepts input voltages from 2.3 V to 5.5 V and outputs 1.8 V, 50 mA. This 1.8V supply is externally available to provide regulated power to peripheral devices such as a TCXO.

The CDC3RL02 is ideal for use in portable end-equipment, such as mobile phones, that require clock buffering with minimal additive phase noise and fan-out capabilities. It is offered in a 0.4-mm pitch wafer-level chip-scale (WCSP) package (0.8 mm × 1.6 mm) and is optimized for very low standby current consumption.

Simplified Block Diagram



Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
CDC3RL02	DSBGA (8)	0.80 mm × 1.60 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.



Table of Contents

1 Features	1	7.1 Functional Block Diagram	9
2 Applications	1	7.2 Device Functional Modes.....	9
3 Description	1	8 Application and Implementation	10
4 Revision History	2	8.1 Application Information.....	10
5 Pin Configuration and Functions	3	8.2 Typical Application	10
6 Specifications	3	9 Device and Documentation Support	12
6.1 Absolute Maximum Ratings	3	9.1 Community Resources.....	12
6.2 ESD Ratings	4	9.2 Trademarks	12
6.3 Recommended Operating Conditions	4	9.3 Electrostatic Discharge Caution	12
6.4 Electrical Characteristics.....	5	9.4 Glossary	12
6.5 Typical Characteristics.....	7	10 Mechanical, Packaging, and Orderable	
7 Detailed Description	9	Information	12

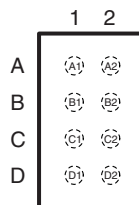
4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Original (November 2009) to Revision A	Page
• Formatted document to new standards.	1

5 Pin Configuration and Functions

**YFP Package
8-Pin DSBGA
Top View**



Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
V _{BATT}	A1	I	Input to internal LDO
CLK_OUT1	A2	O	Clock output 1
V _{LDO}	B1	O	1.8 V I/O supply for CDC3RL02 and external TCXO
CLK_REQ1	B2	I	Clock request from peripheral 2
MCLK_IN	C1	I	Master clock input
CLK_REQ2	C2	I	Clock request from peripheral 1
GND	D1	–	Ground
CLK_OUT2	D2	O	Clock output 2

YFP Package Pin Assignments

	1	2
A	V _{BATT}	CLK_OUT1
B	V _{LDO}	CLK_REQ1
C	MCLK_IN	CLK_REQ2
D	GND	CLK_OUT2

6 Specifications

6.1 Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
V _{BATT} voltage range ⁽²⁾		–0.3	7	V
Voltage range ⁽³⁾	CLK_REQ_1/2, MCLK_IN	–0.3	V _{BATT} + 0.3	V
	V _{LDO} , CLK_OUT_1/2 ⁽²⁾	–0.3	V _{BATT} + 0.3	
I _{IK}	Input clamp current at V _{BATT} , CLK_REQ_1/2, and MCLK_IN V _I < 0		–50	mA
I _O	Continuous output current CLK_OUT1/2		±20	mA
	Continuous current through GND, V _{BATT} , V _{LDO}		±50	mA
T _J	Operating virtual junction temperature	–40	150	°C
T _A	Operating ambient temperature range	–40	85	°C
T _{stg}	Storage temperature range	–55	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

(3) All voltage values are with respect to network ground pin.

6.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$ Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000	
	Machine Model	200	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 500-V HBM is possible with the necessary precautions.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 250-V CDM is possible with the necessary precautions.

6.3 Recommended Operating Conditions⁽¹⁾

			MIN	MAX	UNIT
V_{BATT}	Input voltage		2.3	5.5	V
V_I	Input voltage	MCLK_IN, CLK_REQ1/2	0	1.89	V
V_O	Output voltage	CLK_OUT1/2	0	1.8	V
V_{IH}	High-level input voltage	CLK_REQ1/2	1.3	1.89	V
V_{IL}	Low-level input voltage	CLK_REQ1/2	0	0.5	V
I_{OH}	High-level output current, DC current		–8		mA
I_{OL}	Low-level output current, DC current			8	mA

- (1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. See the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number [SCBA004](#).

6.4 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
LDO							
V _{OUT}	LDO output voltage	I _{OUT} = 50 mA		1.71	1.8	1.89	V
C _{LDO}	External load capacitance			1		10	μF
I _{OUT(SC)}	Short circuit output current	R _L = 0 Ω			100		mA
I _{OUT(PK)}	Peak output current	V _{BATT} = 2.3 V, V _{LDO} = V _{OUT} – 5%				100	mA
PSR	Power supply rejection	V _{BATT} = 2.3V, I _{OUT} = 2 mA,	f _{IN} = 217 Hz and 1 kHz	60			dB
			f _{IN} = 3.25 MHz	40			
t _{su}	LDO startup time	V _{BATT} = 2.3 V , C _{LDO} = 1 μF, CLK_REQ_n to V _{LDO} = 1.71 V		0.2			ms
		V _{BATT} = 5.5 V , C _{LDO} = 10 μF, CLK_REQ_n to V _{LDO} = 1.71 V		1			
Power Consumption							
I _{SB}	Standby current	Device in standby (all V _{CLK_REQ_n} = 0 V)			0.2	1	μA
I _{CCS}	Static current consumption	Device active but not switching			0.4	1	mA
I _{OB}	Output buffer average current	f _{IN} = 26 MHz, C _{LOAD} = 50 pF			4.2		mA
C _{PD}	Output power dissipation capacitance	f _{IN} = 26 MHz				44	pF
MCLK_IN Input							
I _I	MCLK_IN, CLK_REQ_1/2 leakage current	V _I = V _{LDO} or GND				1	μA
C _I	MCLK_IN capacitance	f _{IN} = 26 MHz			4.75		pF
R _I	MCLK_IN impedance	f _{IN} = 26 MHz			6		kΩ
f _{IN}	MCLK_IN frequency range			10	26	52	MHz
MCLK_IN LVCMOS Source							
	Additive phase noise	f _{IN} = 26 MHz, t _r /t _f ≤ 1 ns	1-kHz offset	–140		dBc/Hz	
			10-kHz offset	–149			
			100-kHz offset	–153			
			1-MHz offset	–148			
	Additive jitter	f _{IN} = 26 MHz, V _{PP} = 0.8 V, BW = 10–5 MHz		0.37		ps (rms)	
t _{DL}	MCLK_IN to CLK_OUT_n propagation delay			11		ns	
DC _L	Output duty cycle	f _{IN} = 26 MHz, DC _{IN} = 50%		45	50	55	%

Electrical Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
MCLK_IN Sinusoidal Source							
V _{MA}	Input amplitude			0.3		1.8	V
Additive phase noise	f _{IN} = 26 MHz, V _{MA} = 1.8 V _{PP}	1-kHz offset		–141		dBc/Hz	
		10-kHz offset		–149			
		100-kHz offset		–152			
		1-MHz offset		–148			
	f _{IN} = 26 MHz, V _{MA} = 0.8 V _{PP}	1-kHz offset		–139			
		10-kHz offset		–146			
		100-kHz offset		–150			
		1-MHz offset		–146			
Additive jitter	f _{IN} = 26 MHz, V _{MA} = 1.8 V _{PP} , BW = 10–5 MHz		0.41			ps (RMS)	
t _{DS}	MCLK_IN to CLK_OUT_1/2 propagation delay			12		ns	
DC _S	Output duty cycle	f _{IN} = 26 MHz, V _{MA} > 1.8 V _{PP}		45	50	55	%
CLK_OUT_N Outputs							
t _r	20% to 80% rise time	C _L = 10 pF to 50 pF		1		5.2	ns
t _f	20% to 80% fall time	C _L = 10 pF to 50 pF		1		5.2	ns
t _{sk}	Channel-to-channel skew	C _L = 10 pF to 50 pF (C _{L1} = C _{L2})		–0.5		0.5	ns
V _{OH}	High-level output voltage	I _{OH} = –100 μA, reference to V _{LDO}		–0.1		V	
		I _{OH} = –8 mA		1.2			
V _{OL}	Low-level output voltage	I _{OL} = 20 μA		0.2		V	
		I _{OL} = 8 mA		0.55			

6.5 Typical Characteristics

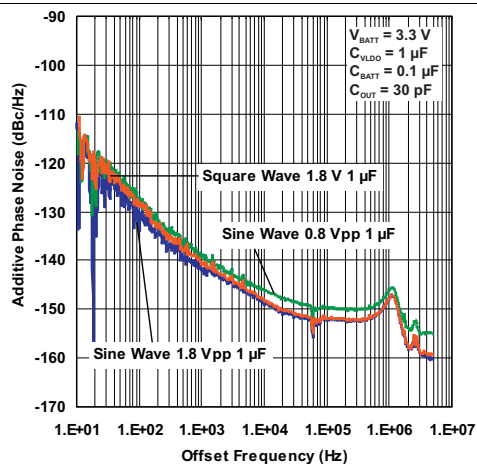


Figure 1. Additive Phase Noise vs Offset Frequency

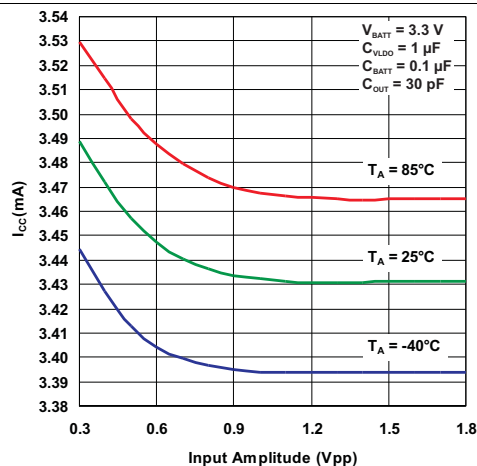


Figure 2. Supply Current vs Input Amplitude

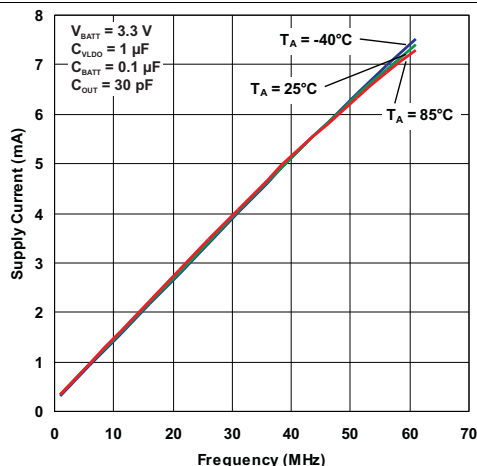


Figure 3. Supply Current vs Input Frequency

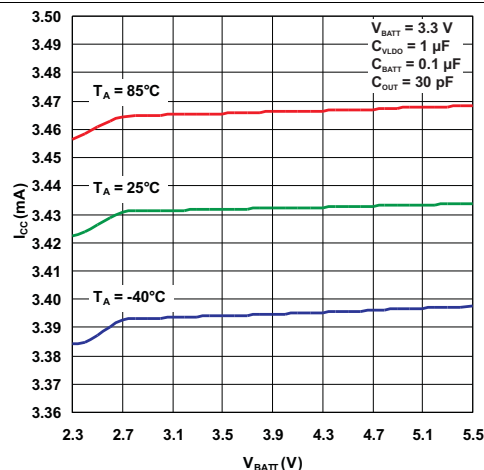


Figure 4. Supply Current vs Supply Voltage

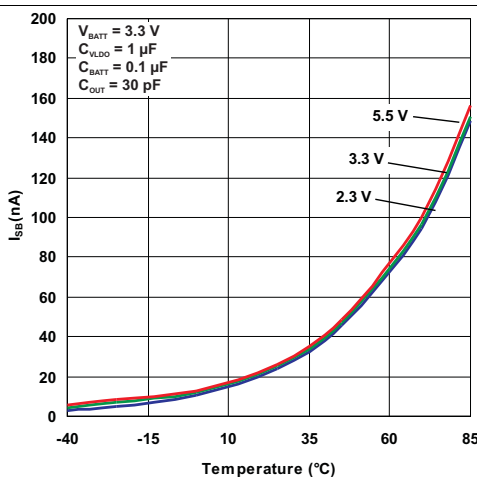


Figure 5. Standby Current vs Temperature

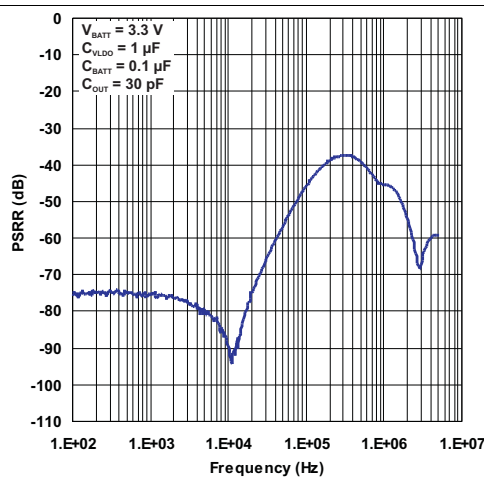


Figure 6. Power Supply Rejection vs Input Frequency

Typical Characteristics (continued)

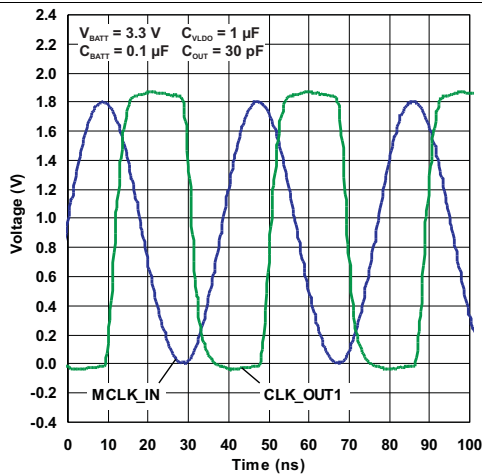


Figure 7. Sine-Wave Input vs Square-Wave Output

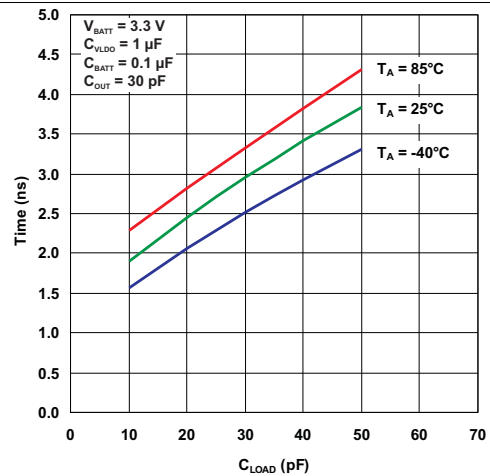


Figure 8. Rise Time vs Load

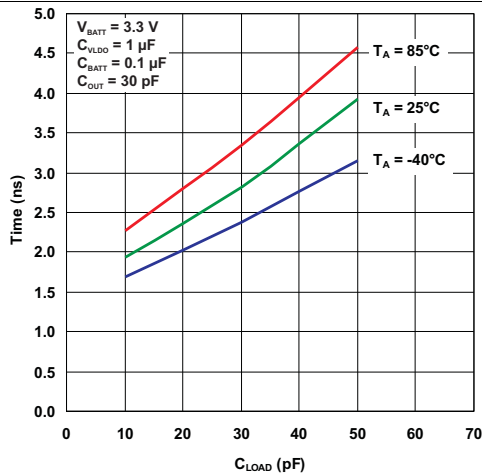


Figure 9. Fall Time vs Load

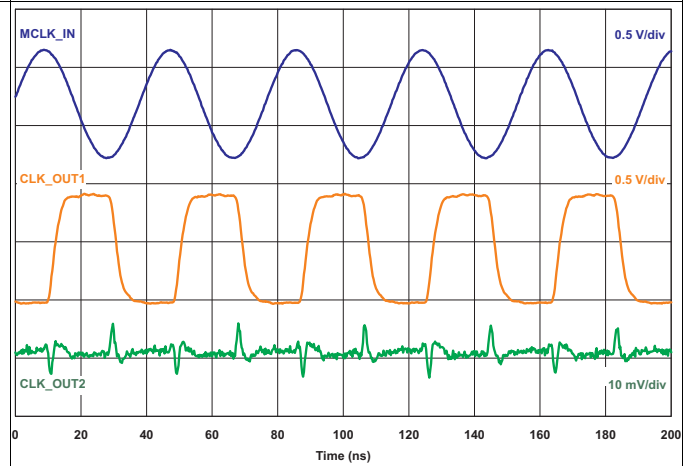
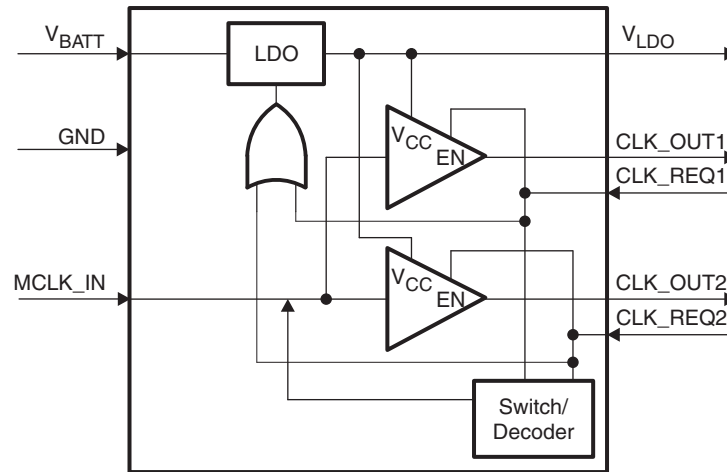


Figure 10. Digital Cross-Talk Scope Shot

7 Detailed Description

7.1 Functional Block Diagram



7.2 Device Functional Modes

Table 1 is the function table for CDC3RL02.

Table 1. Function Table

INPUTS			OUTPUTS	
CLK_REQ1	CLK_REQ2	MCLK_IN	CLK_OUT1	CLK_OUT2
L	L	X	L	L
L	H	CLK	L	CLK
H	L	CLK	CLK	L
H	H	CLK	CLK	CLK

8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

8.1.1 Input Clock Squarer

Figure 11 shows the input stage of the CDC3RL02. The input signal at MCLK_IN can be a square wave or sine wave. CMCLK is an internal AC coupling capacitor that allows a direct connection from the TCXO to the CDC3RL02 without an external capacitor.

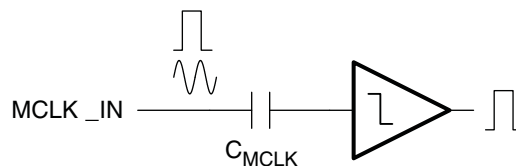


Figure 11. Input Stage

Any external component added in the series path of the clock signal will potentially add phase noise and jitter. The error source associated with the internal decoupling capacitor is included in the specification of the CDC3RL02. The recommended clock frequency band of the CDC3RL02 is 10 MHz to 52 MHz for specified functionality. All performance metrics are specified at 26 MHz. The lowest acceptable sinusoidal signal amplitude is 0.8 V_{PP} for specified performance. Amplitudes as low as 0.3 V_{PP} are acceptable but with reduced phase noise and jitter performance.

8.1.2 Output Stage

Each output drives 1.8-V LVCMOS levels. Adaptive output buffers limit the rise/fall time of the output to within 1 to 5 ns with load capacitance between 10 pF and 50 pF. Fast slew rates introduce EMI into the system. Each output buffer limits EMI by keeping the rise/fall time above 1 ns. Slow rise/fall times can induce additive phase noise and duty cycle errors in the load device. The output buffer limits these errors by keeping the rise/fall time below 5 ns. In addition, the output stage dynamically alters impedance based on the instantaneous voltage level of the output. This dynamic change limits reflections keeping the output signal monotonic during transitions. Each output is active low when not requested to avoid false clocking of the load device.

8.1.3 LDO

A low noise 1.8-V LDO is integrated to provide the I/O supply for the output buffers. The LDO output is externally available to power a clock source such as a TCXO. A clean supply is provided to the clock buffers and the clock source for optimum phase noise performance. The input range of the LDO allows the device to be powered directly from a single cell Li battery. The LDO is enabled by either of the CLK_REQ_N signals. When disabled, the device enters a low power shutdown mode consuming less than 1 µA from the battery. The LDO requires an output decoupling capacitor in the range of 1 µF to 10 µF for compensation and high frequency PSR. This capacitor must stay within the specified range over the entire operating temperature range. An input bypass capacitor of 1 µF or larger is recommended.

8.2 Typical Application

The CDC3RL02 is ideal for use in mobile applications as shown in Figure 12. In this example, a single low noise TCXO system clock source is buffered to drive a mobile GPS receiver and WLAN transceiver. Each peripheral independently requests an active clock by asserting a single clock request line (CLK_REQ_1 or CLK_REQ_2). When both clock request lines are inactive, the CDC3RL02 enters a low current shutdown mode. In this mode, the LDO output, CLK_OUT_1, and CLK_OUT_2 are pulled to GND and the TCXO will be unpowered.

Typical Application (continued)

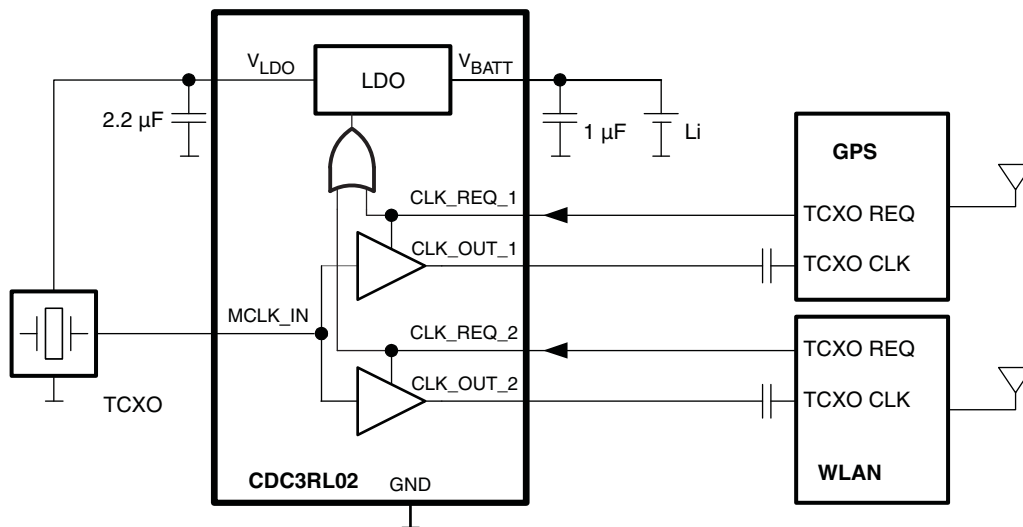


Figure 12. Mobile Application

When either peripheral requests the clock, the CDC3RL02 will enable the LDO and power the TCXO. The TCXO output (square wave, sine wave, or clipped sine wave) is converted to a square wave and buffered to the requested output.

9 Device and Documentation Support

9.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

9.2 Trademarks

E2E is a trademark of Texas Instruments.
All other trademarks are the property of their respective owners.

9.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

9.4 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CDC3RL02BYFPR	ACTIVE	DSBGA	YFP	8	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	4LN	Samples
CDC3RL02YFPR	ACTIVE	DSBGA	YFP	8	3000	Green (RoHS & no Sb/Br)	Call TI SNAGCU	Level-1-260C-UNLIM	-40 to 85	(4L2 ~ 4LN)	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

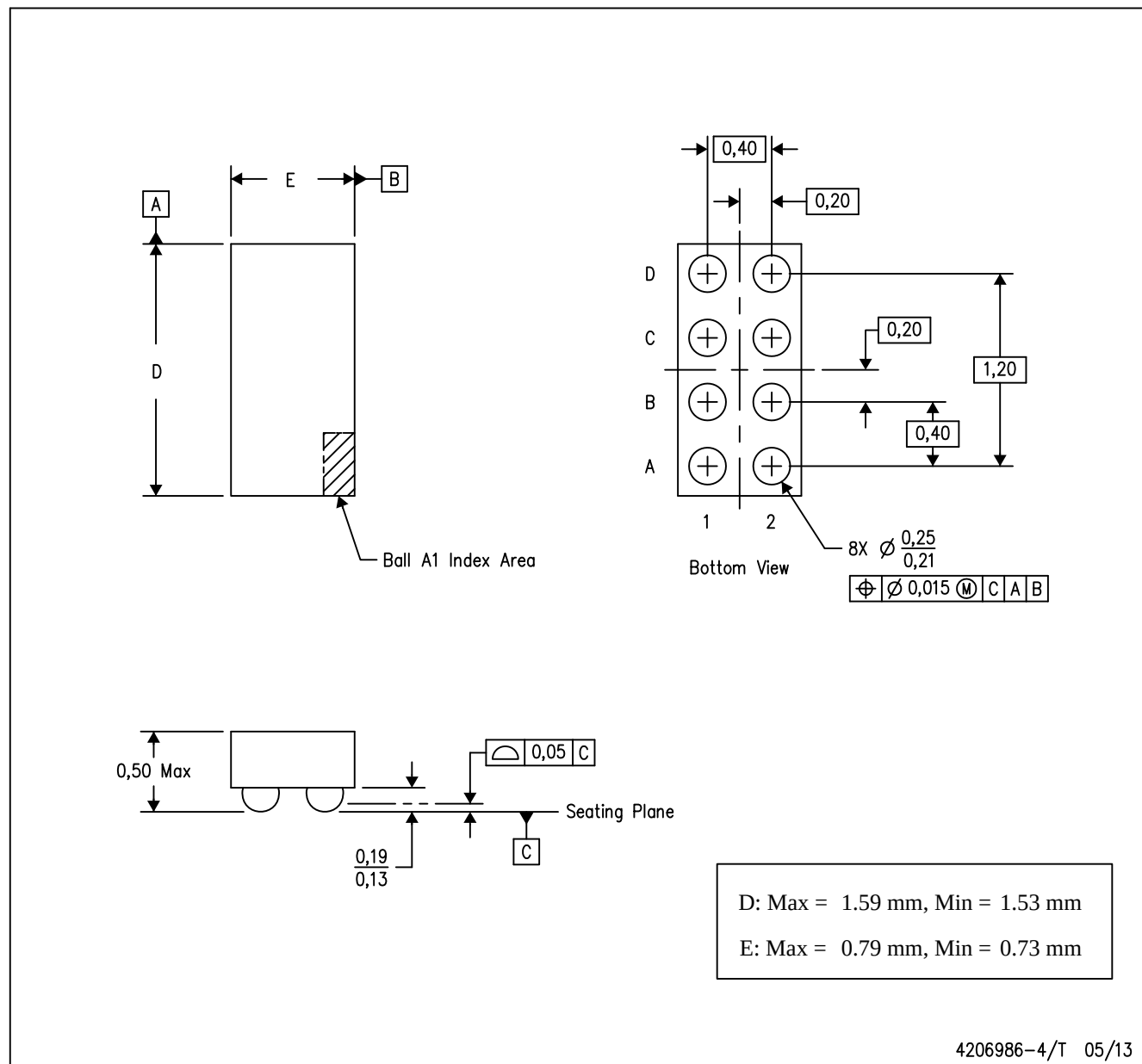
(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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YFP (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - This drawing is subject to change without notice.
 - NanoFree™ package configuration.

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